

## N-Channel Enhancement Mode MOSFET

### Pin Description

### Feature

- Very Low RDS(on) at 4.5V<sub>GS</sub>
- Reliable and Rugged
- ROHS Compliant & Halogen-Free
- 100% UIS and Rg Tested

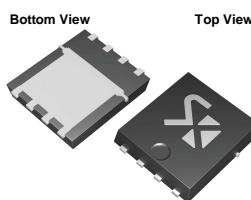
### Applications

- Power Load Switch
- Motor Control

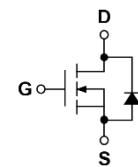
### Product Summary

Symbol	N-Channel	Unit
V <sub>DSS</sub>	30	V
R <sub>DS(ON)-Max</sub>	1	mΩ
I <sub>D</sub>	254	A

PDFN5\*6



Symbol



### Ordering Information

Orderable Part Number	Package Type	Form	Shipping	Marking
SK254N03AD	PDFN5*6	Tape & Reel	5000 / Tape & Reel	254N03

Note :

### Absolute Maximum Ratings (T<sub>J</sub>=25°C Unless Otherwise Noted)

Symbol	Parameter	N-Channel	Unit
V <sub>DSS</sub>	Drain-Source Voltage	30	V
V <sub>GES</sub>	Gate-Source Voltage	±20	
T <sub>J</sub>	Maximum Junction Temperature	150	°C
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C
I <sub>S</sub>	Diode Continuous Forward Current	87	A
I <sub>DM</sub> <sup>(1)</sup>	Pulse Drain Current Tested	T <sub>C</sub> =25°C 400	A
I <sub>D</sub>	Continuous Drain Current	T <sub>C</sub> =25°C 254	
		T <sub>C</sub> =100°C 160	A
P <sub>D</sub>	Maximum Power Dissipation	T <sub>C</sub> =25°C 96	W
		T <sub>C</sub> =100°C 39	
I <sub>D</sub>	Continuous Drain Current	T <sub>A</sub> =25°C 42	
		T <sub>A</sub> =70°C 33	A
P <sub>D</sub>	Maximum Power Dissipation	T <sub>A</sub> =25°C 2.5	W
		T <sub>A</sub> =70°C 1.6	
I <sub>AS</sub> <sup>(2)</sup>	Avalanche Current, Single pulse	L=0.3mH 50	A
E <sub>AS</sub> <sup>(2)</sup>	Avalanche Energy, Single pulse	L=0.3mH 375	mJ

### Thermal Characteristics

Symbol	Parameter	Rating	Unit
R <sub>θJC</sub>	Thermal Resistance-Junction to Case	Steady State 1.3	°C/W
R <sub>θJA</sub> <sup>(3)</sup>	Thermal Resistance-Junction to Ambient	Steady State 50	°C/W

Note ① : Max. current is limited by bonding wire

Note ② : UIS tested and pulse width are limited by maximum junction temperature 150°C

Note ③ : Surface Mounted on 1in<sup>2</sup> FR-4 board with 1oz.

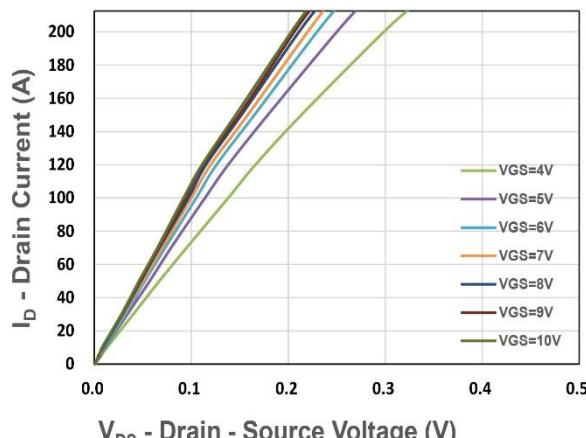
N-Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$  Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
<b>Static Electrical Characteristics</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{DS}}=250\mu\text{A}$	30	-	-	V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}}=24\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	$\mu\text{A}$
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{DS}}=250\mu\text{A}$	1	1.5	2	V
$I_{\text{GSS}}$	Gate Leakage Current	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	$\pm 100$	nA
$R_{\text{DS}(\text{ON})}^{\text{(4)}}$	Drain-Source On-state Resistance	$V_{\text{GS}}=10\text{V}, I_{\text{DS}}=20\text{A}$	-	0.85	1	mΩ
		$V_{\text{GS}}=4.5\text{V}, I_{\text{DS}}=15\text{A}$	-	1.1	1.4	
$g_{\text{fs}}$	Forward Transconductance	$V_{\text{DS}}=5\text{V}, I_{\text{DS}}=10\text{A}$	-	54	-	S
<b>Dynamic Characteristics <sup>(5)</sup></b>						
$R_{\text{G}}$	Gate Resistance	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=0\text{V},$ $\text{Freq.}=1\text{MHz}$	-	4	-	Ω
$C_{\text{iss}}$	Input Capacitance	$V_{\text{GS}}=0\text{V},$ $V_{\text{DS}}=15\text{V},$ $\text{Freq.}=1\text{MHz}$	-	6545	-	pF
$C_{\text{oss}}$	Output Capacitance		-	996	-	
$C_{\text{rss}}$	Reverse Transfer Capacitance		-	772	-	
$t_{\text{d}(\text{ON})}$	Turn-on Delay Time	$V_{\text{GS}}=10\text{V}, V_{\text{DS}}=15\text{V},$ $I_{\text{D}}=1\text{A}, R_{\text{GEN}}=6\Omega$	-	14	-	nS
$t_{\text{r}}$	Turn-on Rise Time		-	24.1	-	
$t_{\text{d}(\text{OFF})}$	Turn-off Delay Time		-	330	-	
$t_{\text{f}}$	Turn-off Fall Time		-	133.5	-	
$Q_{\text{g}}$	Total Gate Charge	$V_{\text{GS}}=4.5\text{V}, V_{\text{DS}}=15\text{V}$ $I_{\text{D}}=20\text{A}$	-	84	-	nC
$Q_{\text{g}}$	Total Gate Charge	$V_{\text{GS}}=10\text{V}, V_{\text{DS}}=15\text{V},$ $I_{\text{D}}=20\text{A}$	-	175.7	-	
$Q_{\text{gs}}$	Gate-Source Charge		-	30.6	-	
$Q_{\text{gd}}$	Gate-Drain Charge		-	30	-	
<b>Source-Drain Characteristics</b>						
$V_{\text{SD}}^{\text{(4)}}$	Diode Forward Voltage	$I_{\text{SD}}=10\text{A}, V_{\text{GS}}=0\text{V}$	-	0.7	1.1	V
$t_{\text{rr}}$	Reverse Recovery Time	$I_{\text{F}}=10\text{A}, V_{\text{R}}=15\text{V}$	-	36.9	-	nS
$Q_{\text{rr}}$	Reverse Recovery Charge		$dI_{\text{F}}/dt=100\text{A}/\mu\text{s}$	-	35.6	-

Note <sup>(4)</sup> : Pulse test (pulse width $\leq 300\mu\text{s}$ , duty cycle $\leq 2\%$ ).

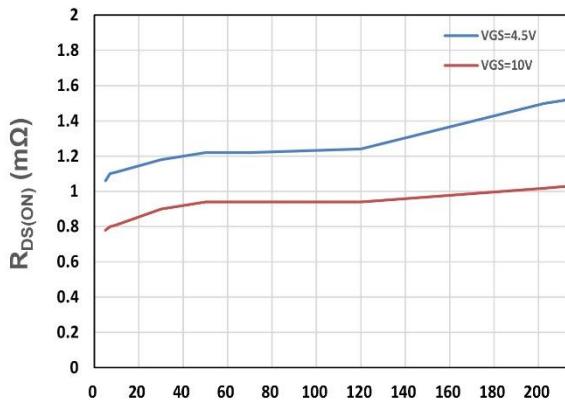
Note <sup>(5)</sup> : Guaranteed by design, not subject to production testing.

## N-Channel Typical Characteristics



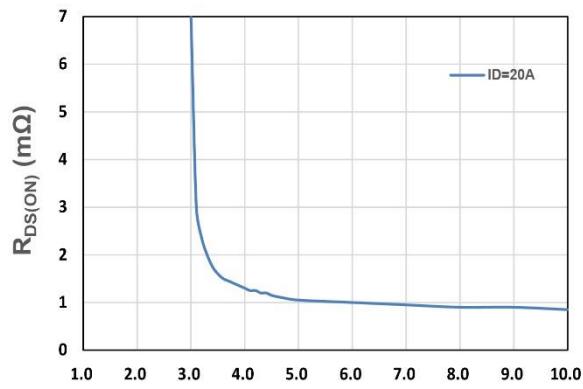
$V_{DS}$  - Drain - Source Voltage (V)

Figure 1. Output Characteristics



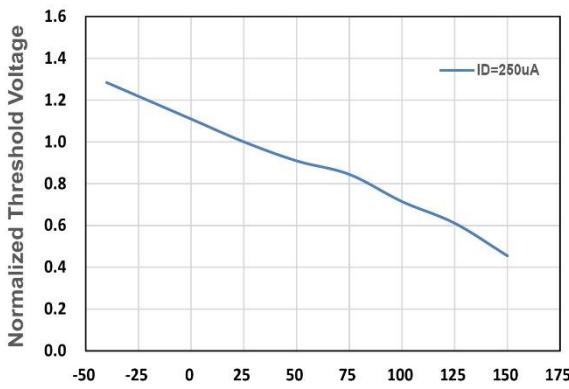
$I_D$ - Drain Current (A)

Figure 2. On-Resistance vs. ID



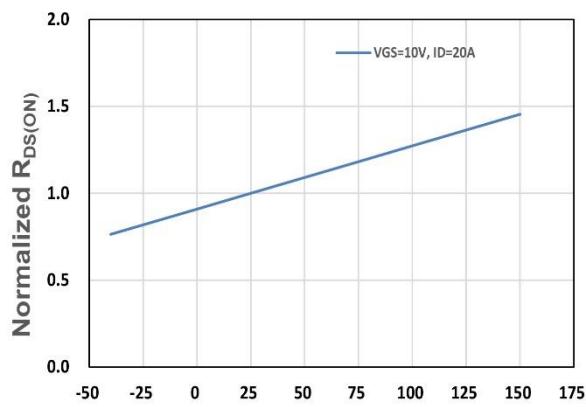
$V_{GS}$  - Gate - Source Voltage (V)

Figure 3. On-Resistance vs. VGS



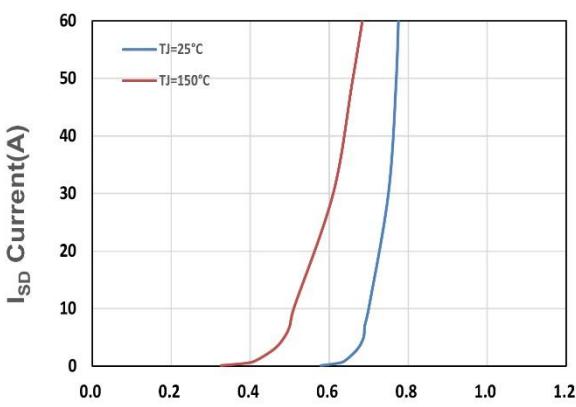
$T_j$ , Junction Temperature(°C)

Figure 4. Gate Threshold Voltage



$T_j$ , Junction Temperature(°C)

Figure 5. Drain-Source On Resistance



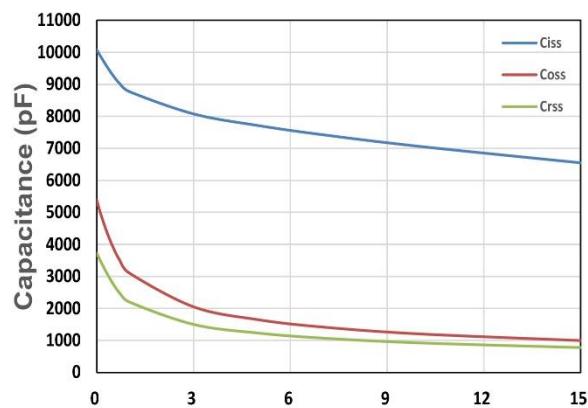
$V_{SD}$ , Source-Drain Voltage(V)

Figure 6. Source-Drain Diode Forward

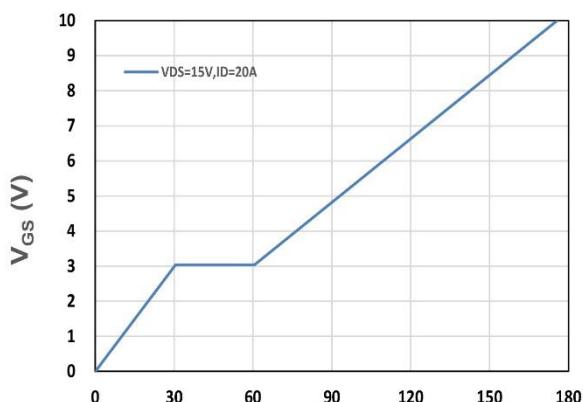


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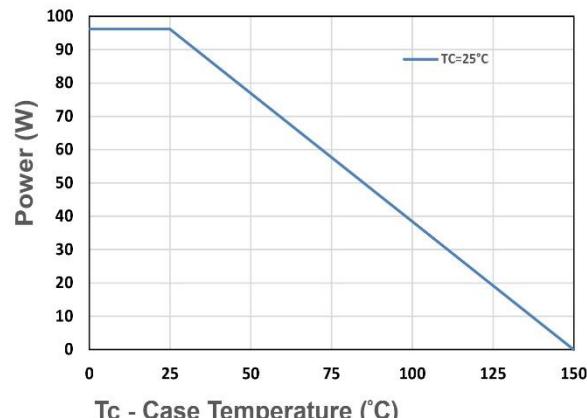
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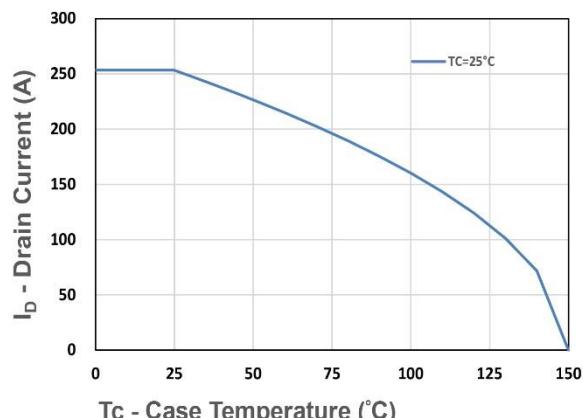
$V_{DS}$  - Drain - Source Voltage (V)  
Figure 7. Capacitance



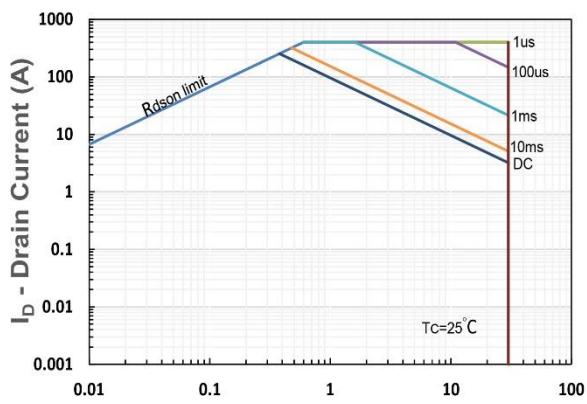
$Q_g$ , Total Gate Charge (nC)  
Figure 8. Gate Charge Characteristics



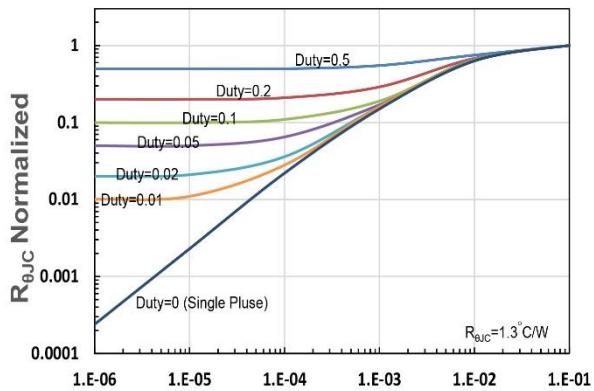
$T_c$  - Case Temperature (°C)  
Figure 9. Power Dissipation



$T_c$  - Case Temperature (°C)  
Figure 10. Drain Current



$V_{DS}$  - Drain-Source Voltage (V)  
Figure 11. Safe Operating Area



$t_1$ , Square Wave Pulse Duration(s)  
Figure 12.  $R_{eJC}$  Transient Thermal Impedance